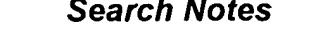


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/612,668	JONES ET AL.
	Examiner	Art Unit
	Michael Szperka	1644

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
STIC sequence search SEQ ID NO:17, 19, 21, and 23		3/27/2006	MS